

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 292873US0PCT		SERIAL NO. 10/584,052	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Stephane POCAS, et al.			
FILING DATE June 22, 2006				GROUP 2892			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION				
			YES		NO		
AO							
AP							
AQ							
AR							
AS							
AT							
AU							
AV							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
/E.J./	AW	Hartmut BRACHT, "DIFFUSION MECHANISMS AND INTRINSIC POINT-DEFECT PROPERTIES IN SILICON", www.mrs.org/publications/bulletin, MRS Bulletin/June 2000, pages 22-27.					
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner /Eric Jones/						Date Considered 11/10/2009	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							